



Simulation Methods for Electrostatic MEMS Switches and Resonators

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NXP Semiconductors

- ▶ Established in September 2006 (formerly a division of Philips)
- ▶ ~38,000 employees
- ▶ Headquarters: Eindhoven, The Netherlands
- ▶ Main product: transistors on Silicon
- ▶ But also other electronic devices on Silicon...

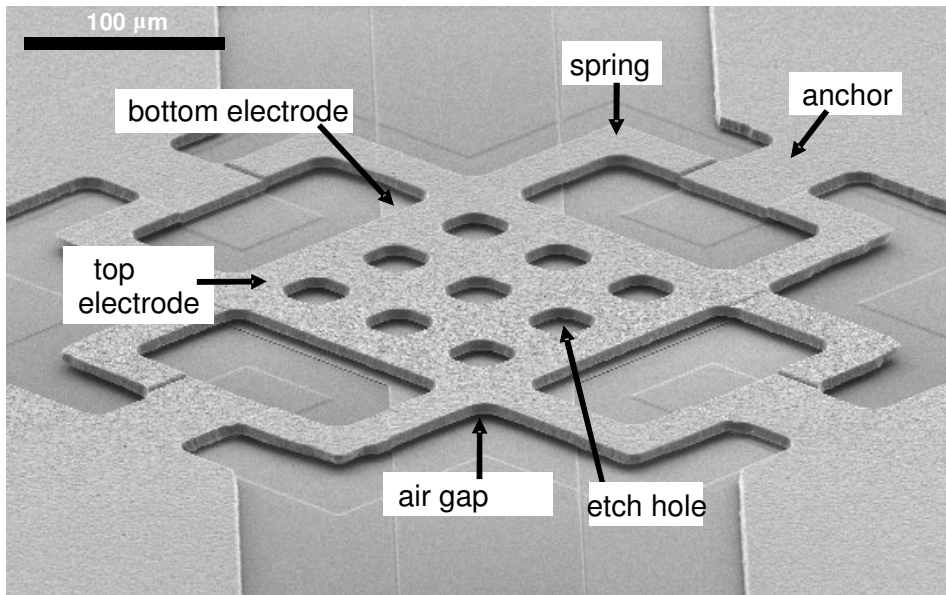


Outline

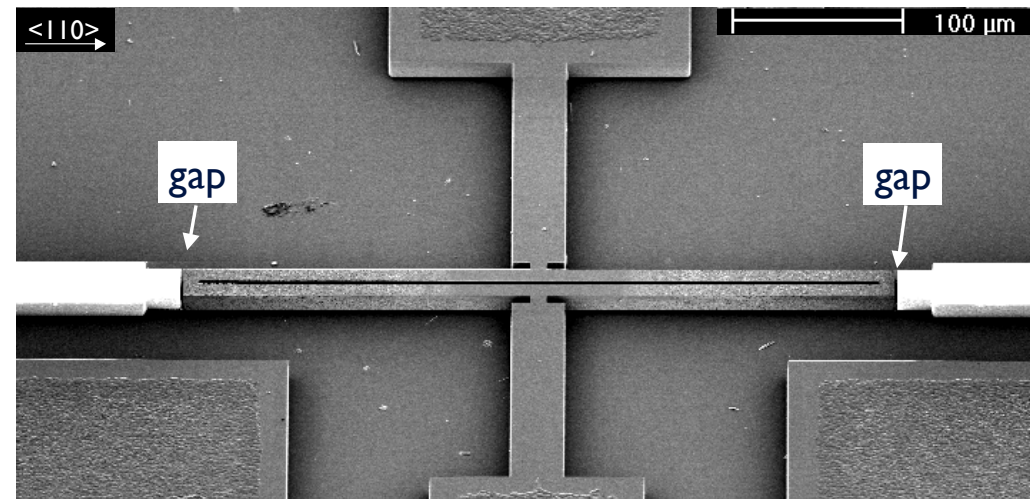
MEMS: Micro Electrical Mechanical Systems

- ▶ RF MEMS switches
 - Calculation of the C-V curve using Comsol
- ▶ MEMS resonators
 - Equivalent parameters m , k and Q of a MEMS resonator using Comsol

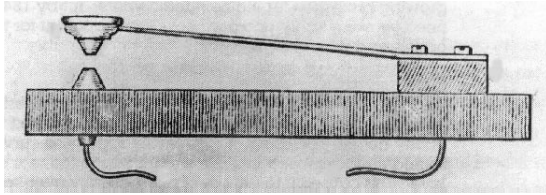
RF MEMS capacitive switch



MEMS resonator



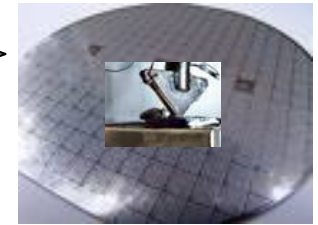
Electrical switches



Morse telegraph key (1844)
Mechanical switch

Advantages

- Low loss/resistance
- High linearity
- High power handling



Transistor (1947)
Semiconductor switch

Advantages:

- Very small size
- High switching speed
- Low cost



Radio Frequency MicroElectroMechanical Switch (RF MEMS)

Best of both worlds: Mechanical switch on semiconductor substrate.

- Low loss
- High linearity
- High RF power handling
- Intermediate size
- Intermediate switching speed
- Intermediate cost

RF MEMS switch physics

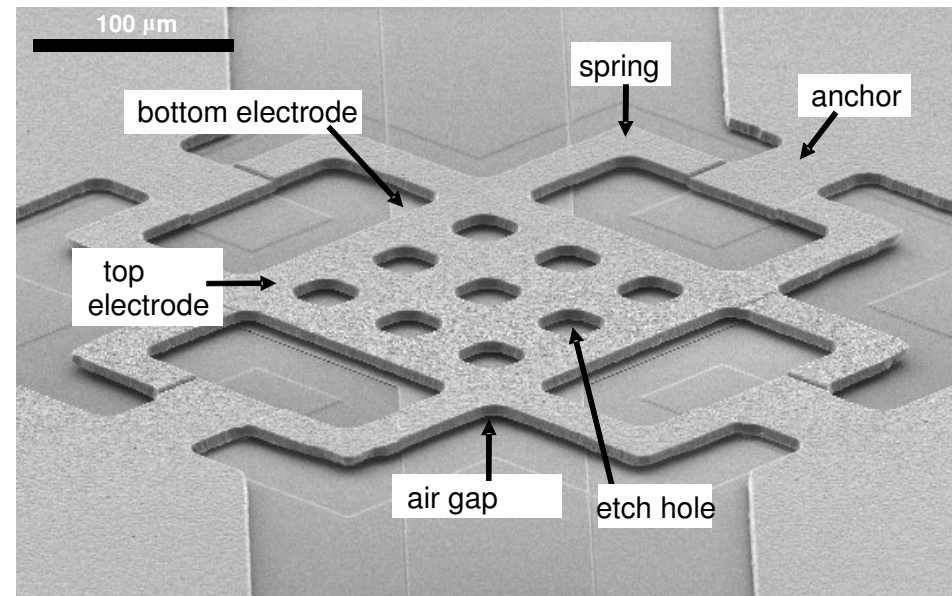
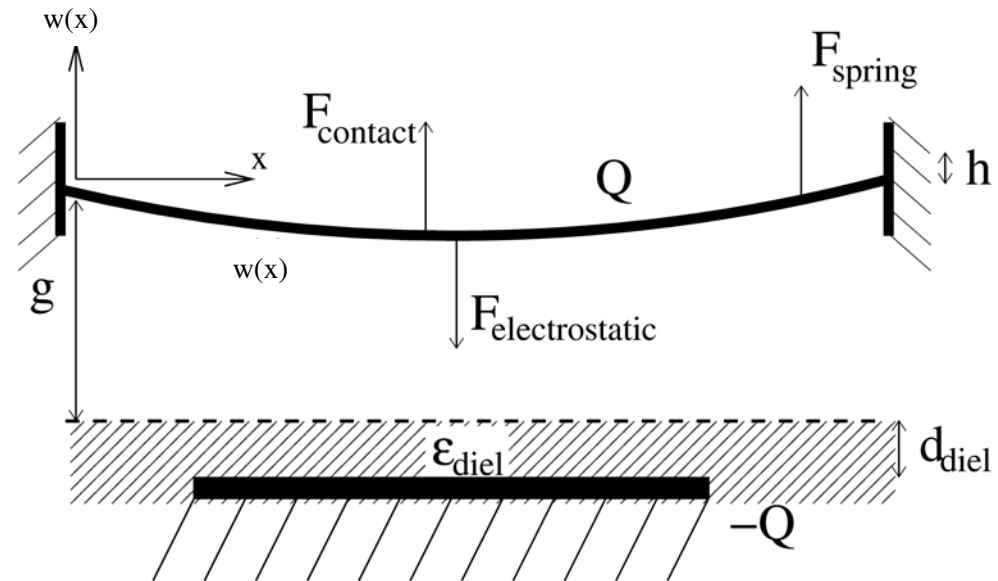
▶ Forces

▶ Static

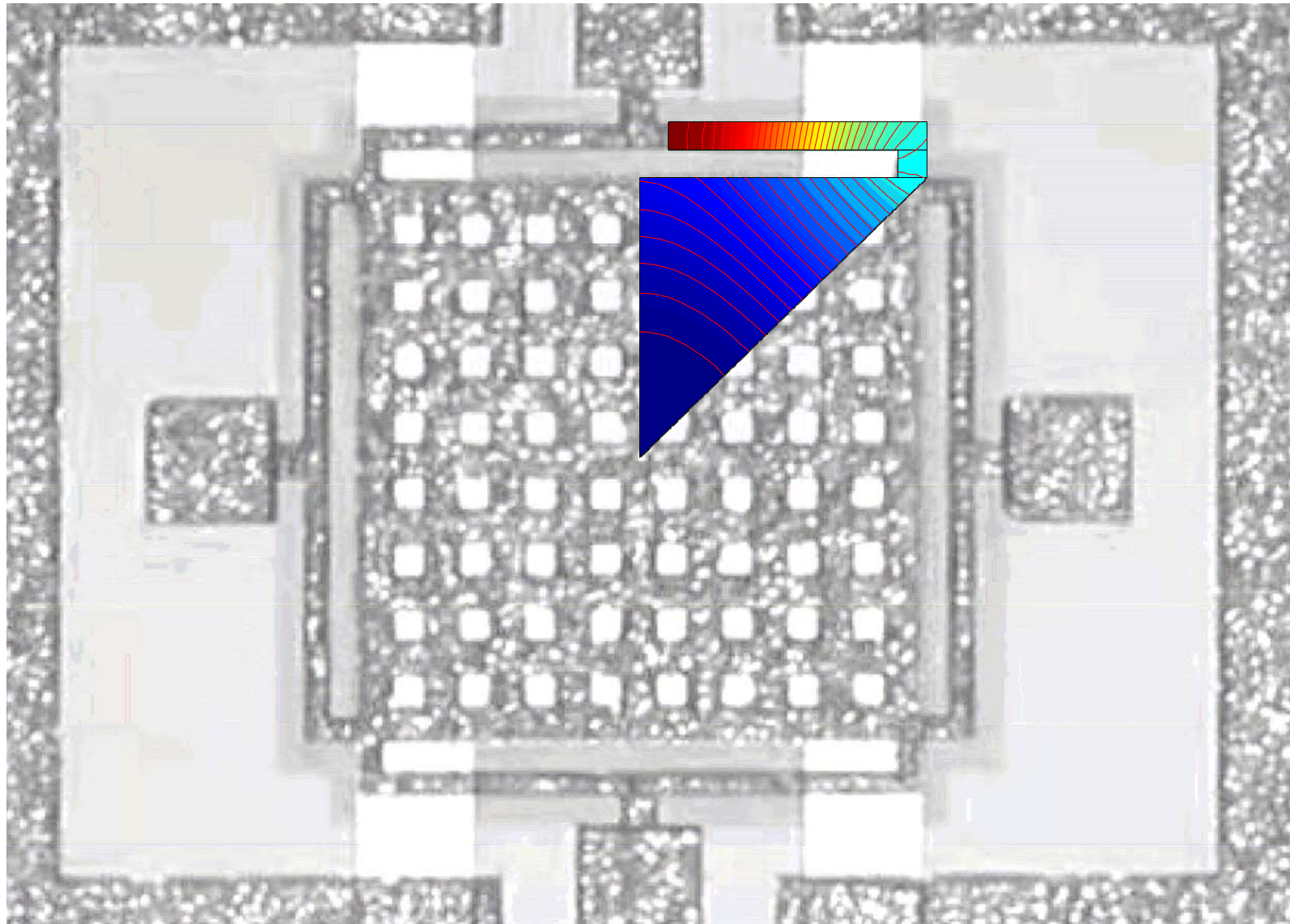
- Spring forces
- Electrostatic force
- Contact force

▶ Dynamics

- Gas damping force
- Inertial forces



MEMS switch under study



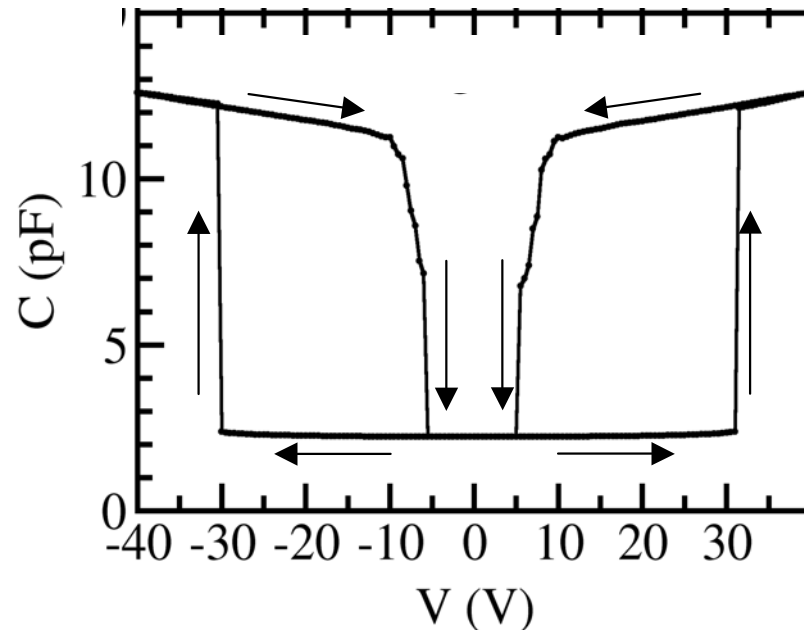
MEMS Capacitance-Voltage curve in Comsol

- ▶ Approximations:
 - Electrostatic parallel plate approximation.
 - Use Mindlin elements for mechanical domain.
 - Hard contact.
- ▶ Simulation in Comsol structural mechanics domain
 - Implement electrostatic and contact forces as pressures on the structure.

Parametric solver

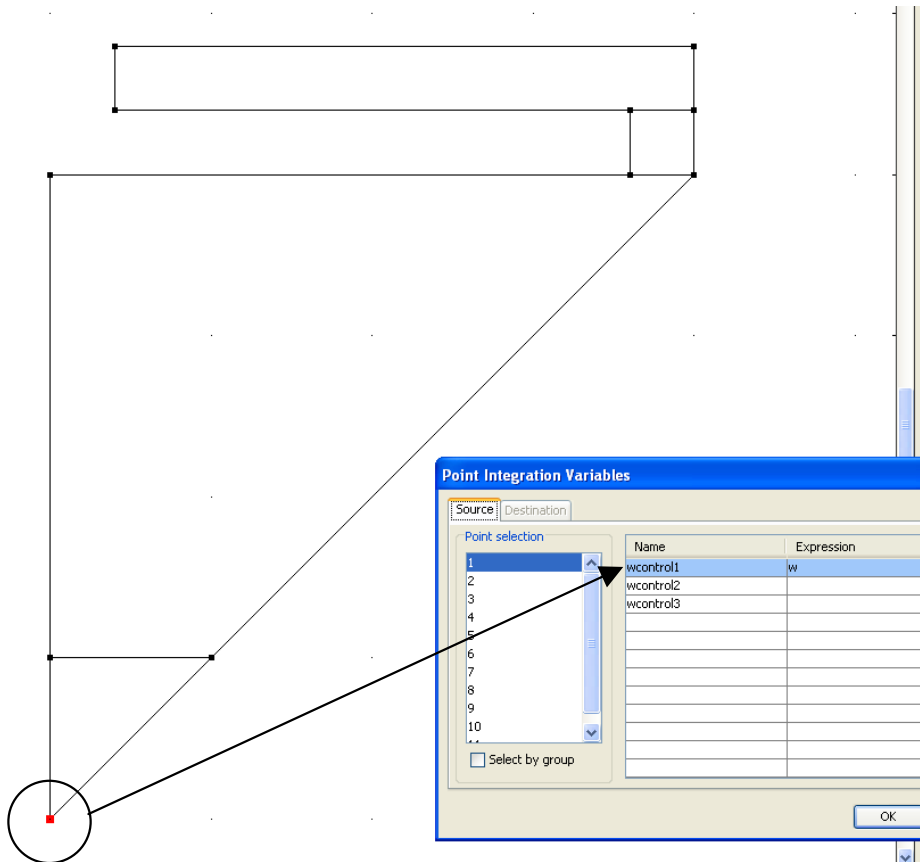
- ▶ How to get $C(V)$?
- ▶ Problem with voltage control:
 - Multiple solutions for 1 voltage.
 - Discontinuities in the shape at pull-in and release voltage.
 - Convergence problems.

- ▶ Solution:
 - Position control of control node.
 - Determine C and V at each position.



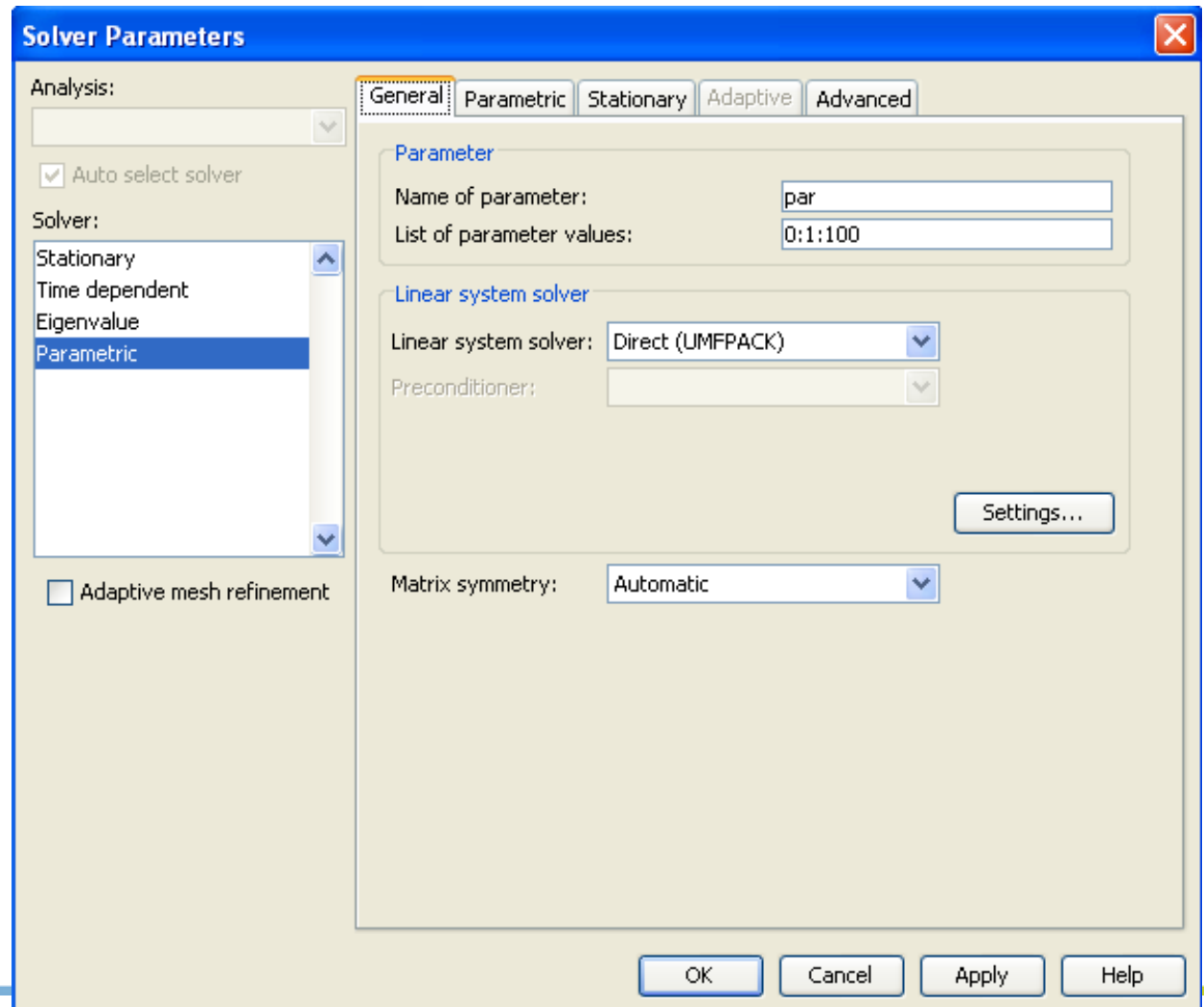
Implementation of position control in Comsol

- ▶ Define point integration variable wcontrol1 on control node.



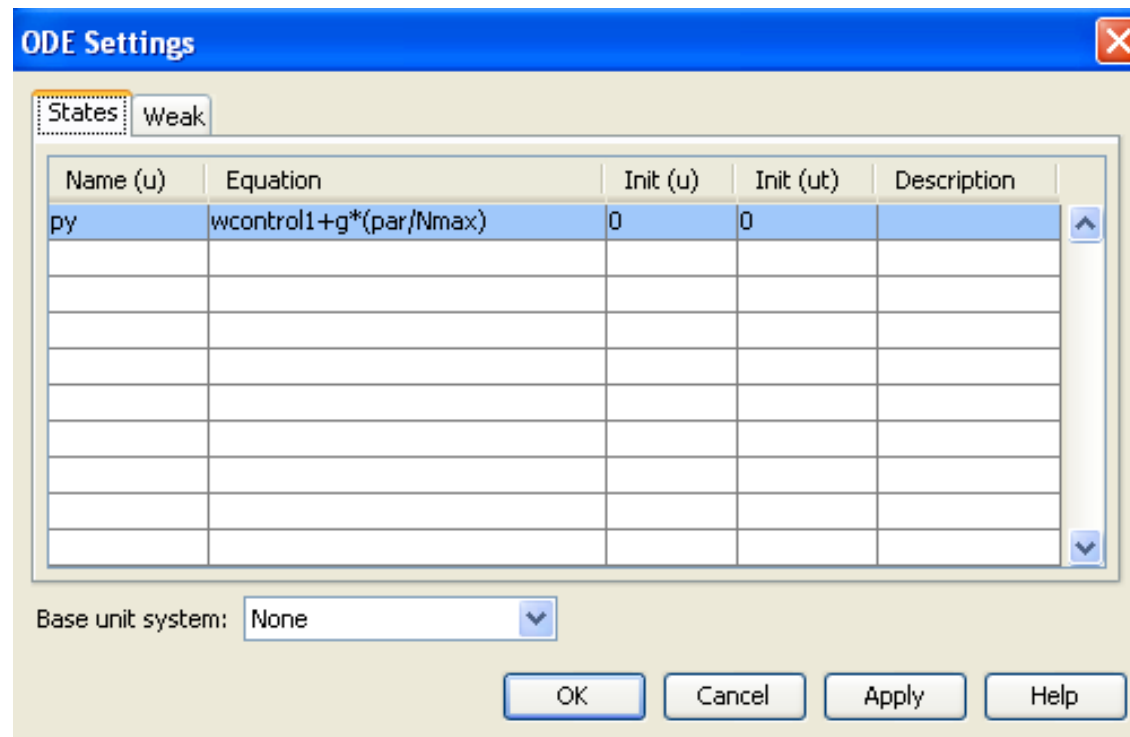
Parametric solver

- ▶ Parameter par goes from 0-100.
- ▶ $wset = -g \cdot par / 100$.



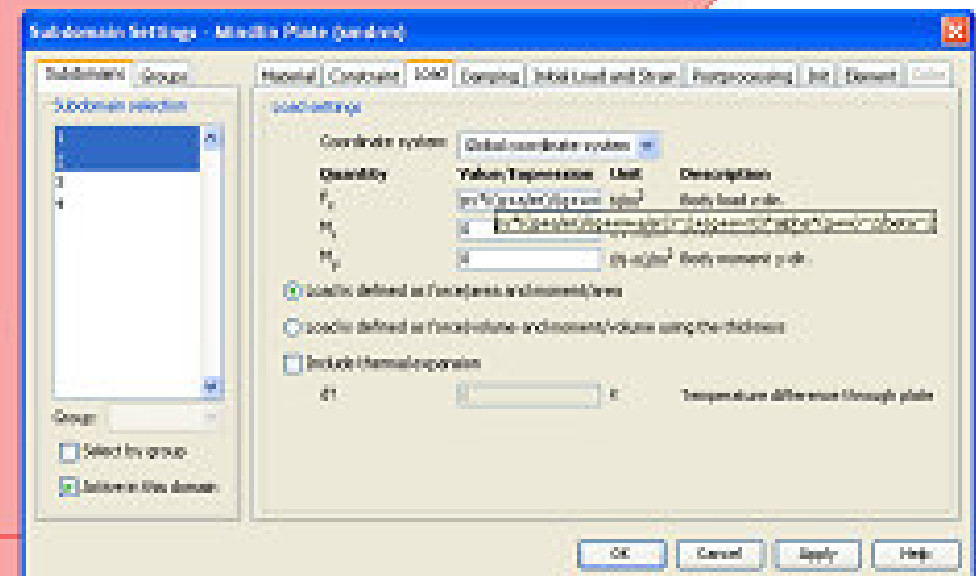
Define extra degree of freedom py

- ▶ ODE will vary py until: $wcontrol1=wset$ ($wset=-g*par/100$)
- ▶ This will ensure that the control node is moved from open to closed position.

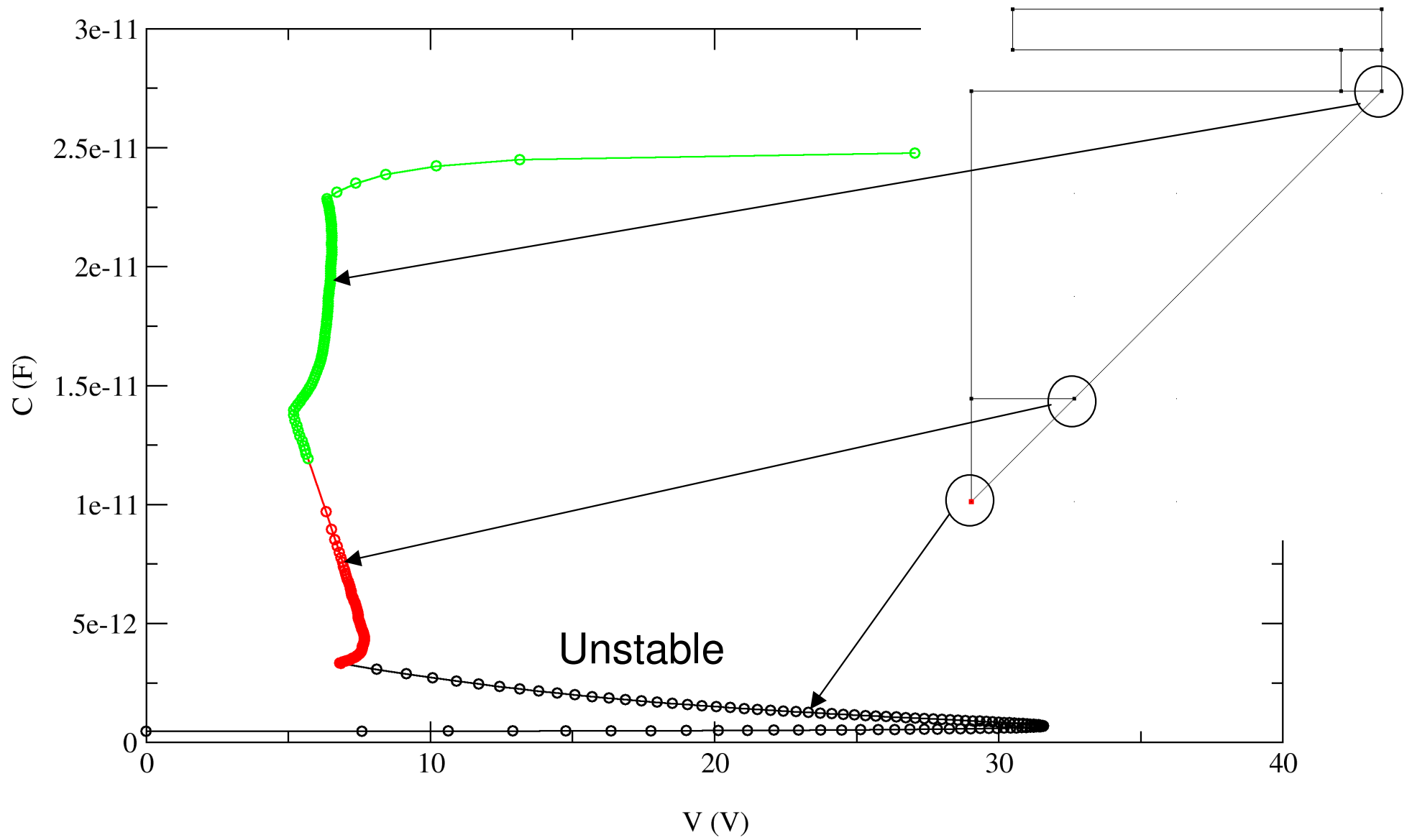


Apply adaptive electrostatic and contact force

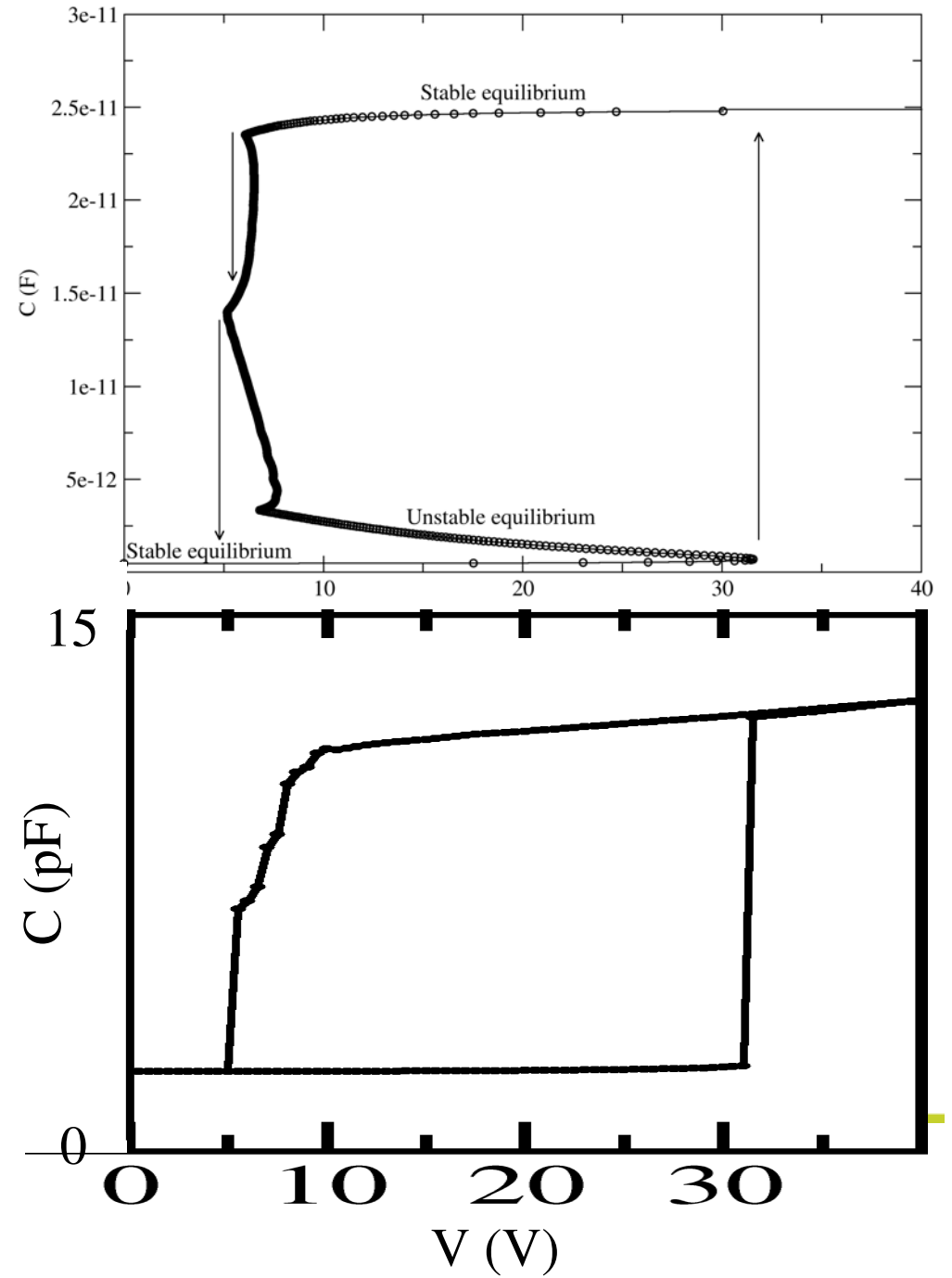
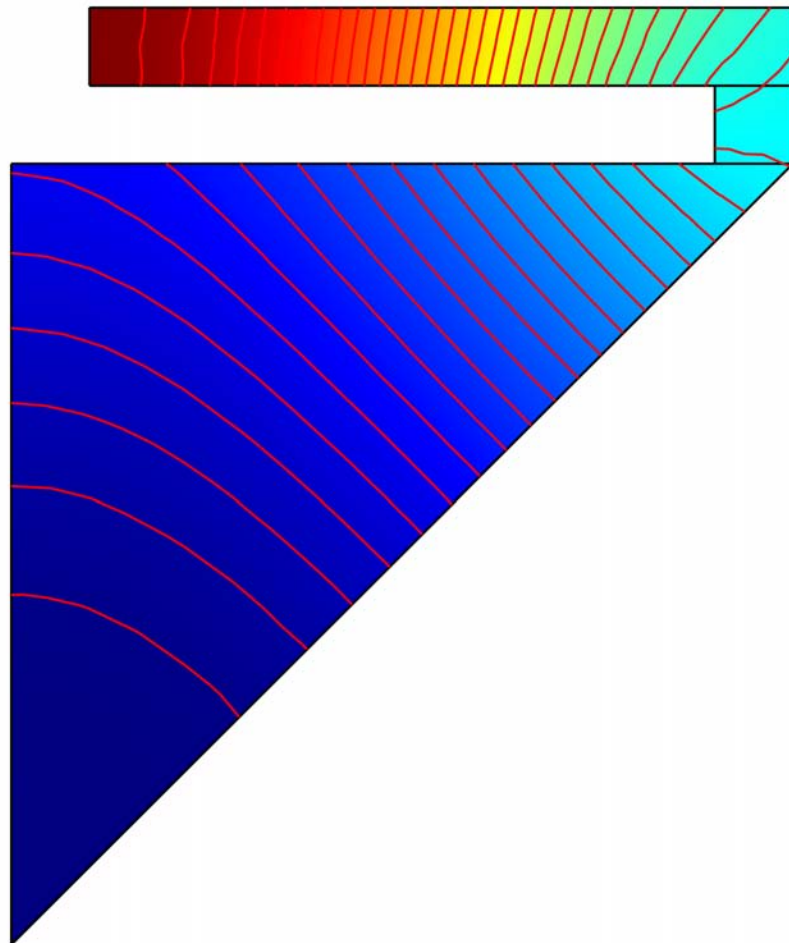
- ▶ In Comsol a pressure $P_e = \rho y^* (g+a/\epsilon_r)^2 / (g+w+a/\epsilon_r)^2 = V^2 / 2\epsilon_0 (g+w+a/\epsilon_r)^2$ is applied.
- ▶ Extra degree of freedom $\rho y \propto V^2$
- ▶ The ODE finds V^2 such that $w_{control1} = w_{set}$!
- ▶ C is obtained from subdomain integration: $C = \int dA \epsilon_0 / (g+w+a/\epsilon_r)$.
- ▶ Contact pressure is modelled by a steep parabola if $(g+w < 0)$.
- ▶ C(V) curve is obtained.



Calculated CV curve



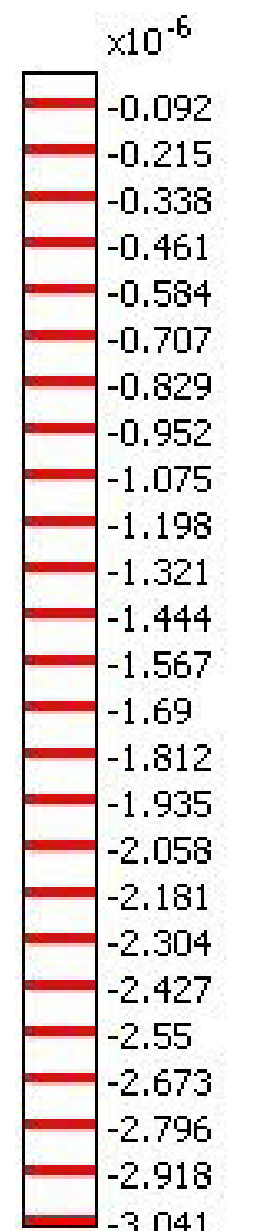
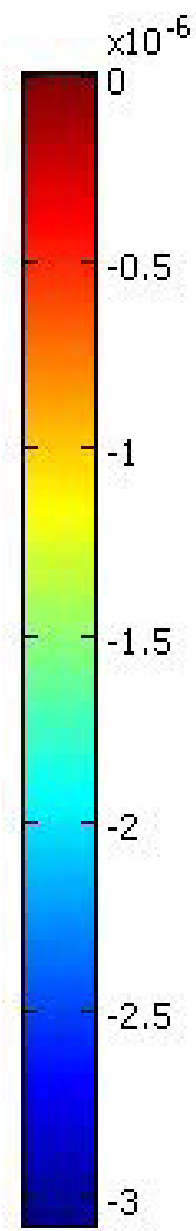
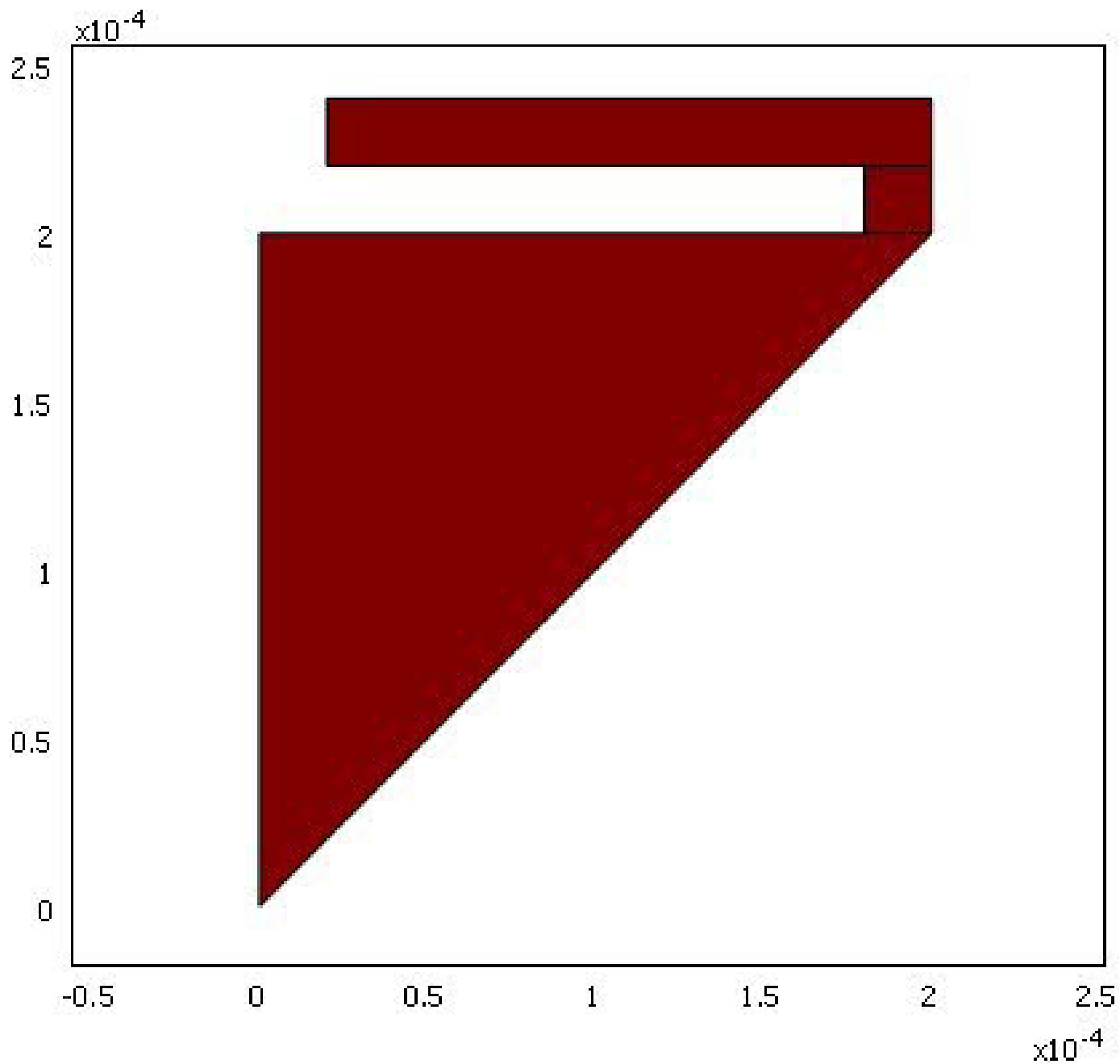
Simulation and measurement



disp0(50)=5e-10 Surface: z-displacement [m]

Max: 4.564e-21

Max: -3.072e-8

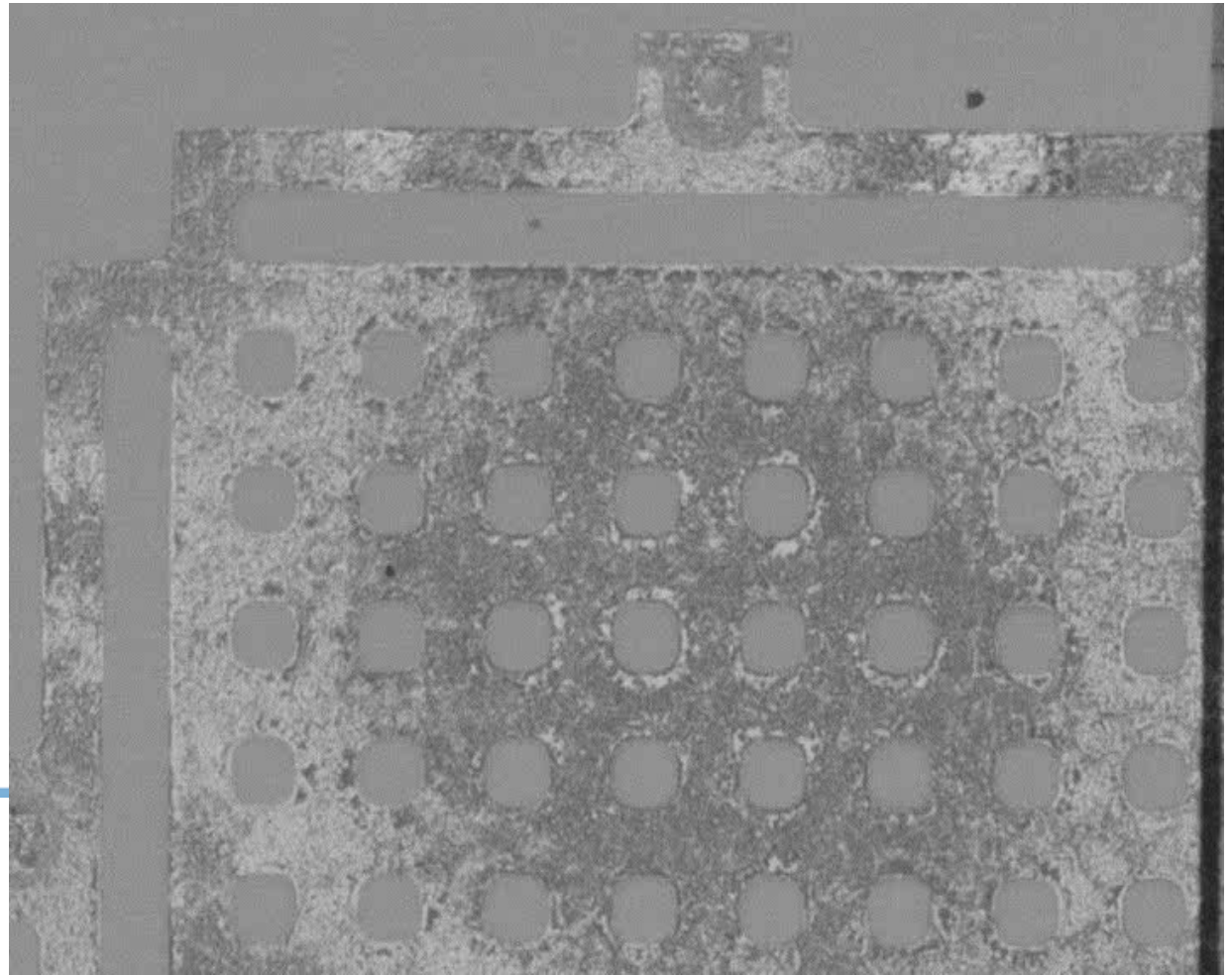


Min: -3.072e-6

Min: -3.041e-6

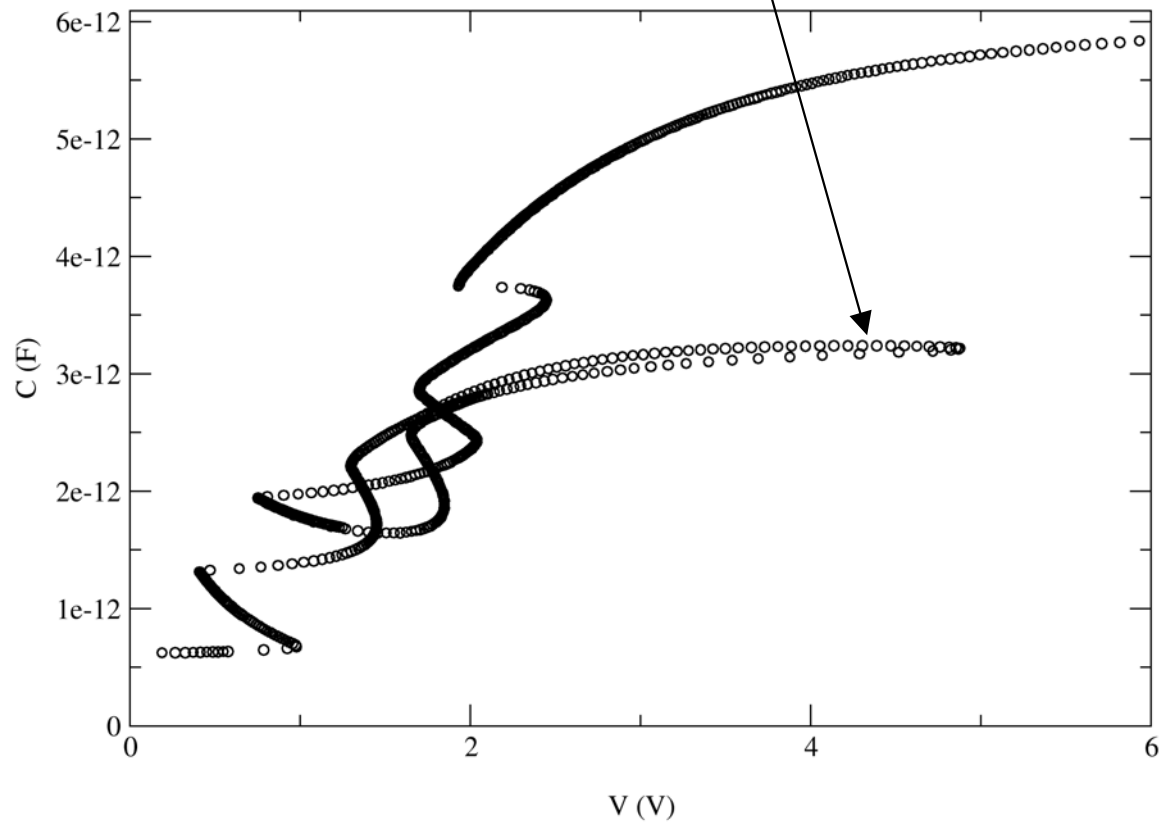
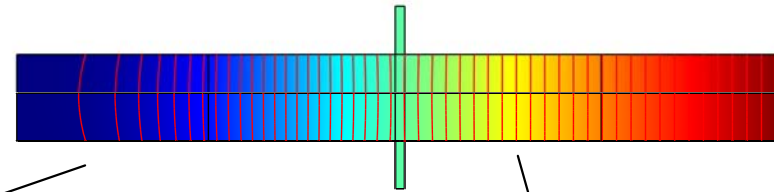
Outlook: dynamics

- ▶ Each second in the interferometric slow-motion movie is about 2 μs in reality
- ▶ If we would play a 1 hour movie recording of the switch at this slow-motion rate, we would not be able to see the end of the movie within our lifetime.
- ▶ Therefore I only show 50 μs .



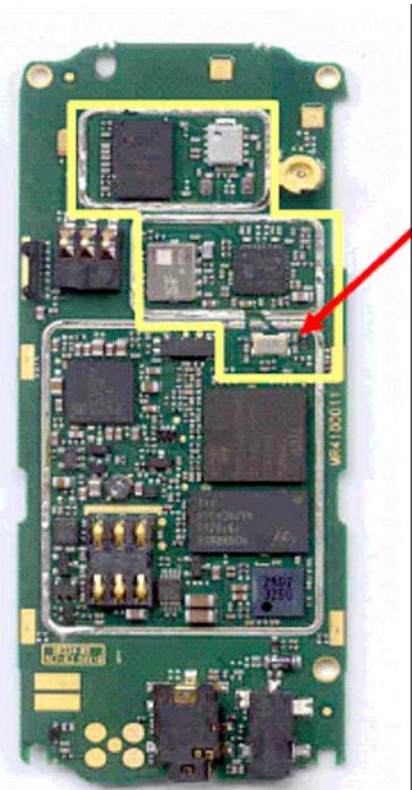
More complications

Electrostatic see-saw structure



MEMS resonators

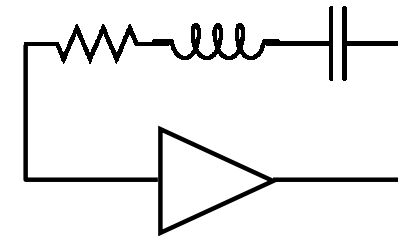
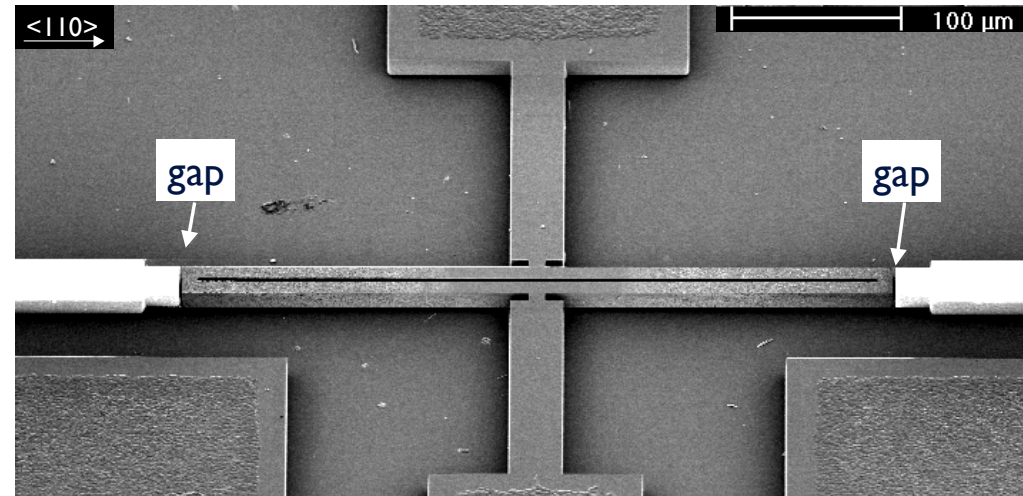
- ▶ Application:
 - Oscillator (clock)



Quartz resonator is large and expensive

Goal: replace
Quartz crystal by
Silicon crystal

MEMS resonator

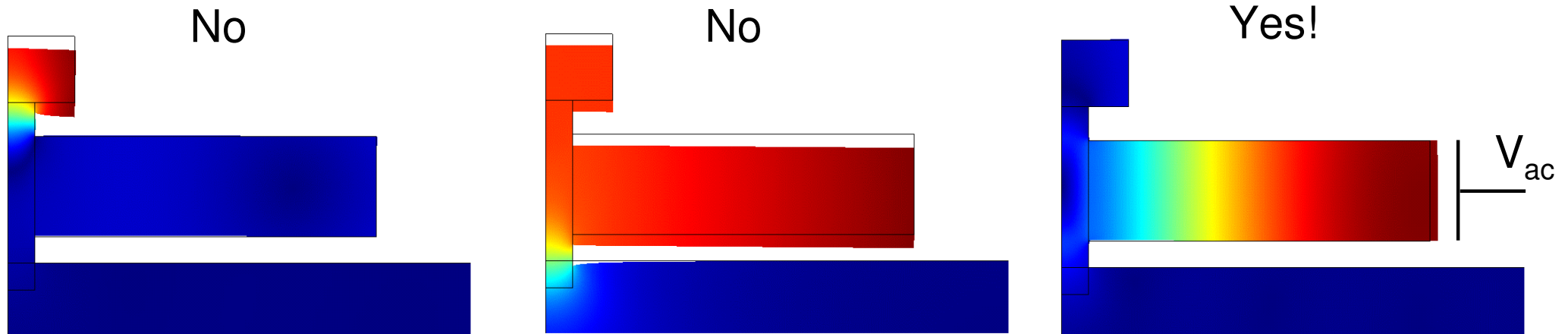


J.T.M. van Beek, P.G. Steeneken and Ben Giesbers, 'A 10 MHz Piezoresistive MEMS Resonator with High-Q'. Proceedings International Frequency Control Symposium 2006 (Miami).



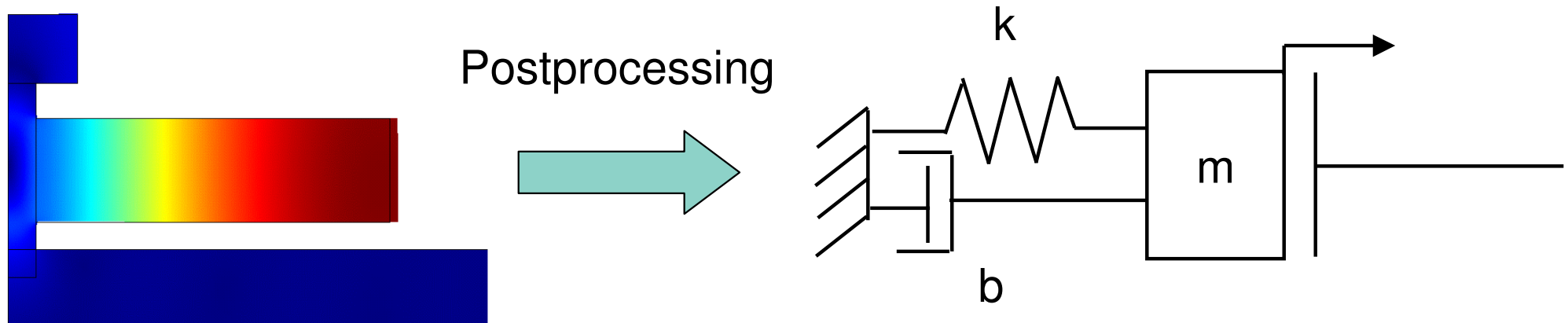
Simulating MEMS resonators

- ▶ Simplistic way to analyze MEMS resonators with Comsol:
 - Put geometry and material parameters in Comsol.
 - Run eigenfrequency analysis.
 - Select required mode shape by hand.
 - Examine frequency.
- ▶ How can we get more information from this simulation?



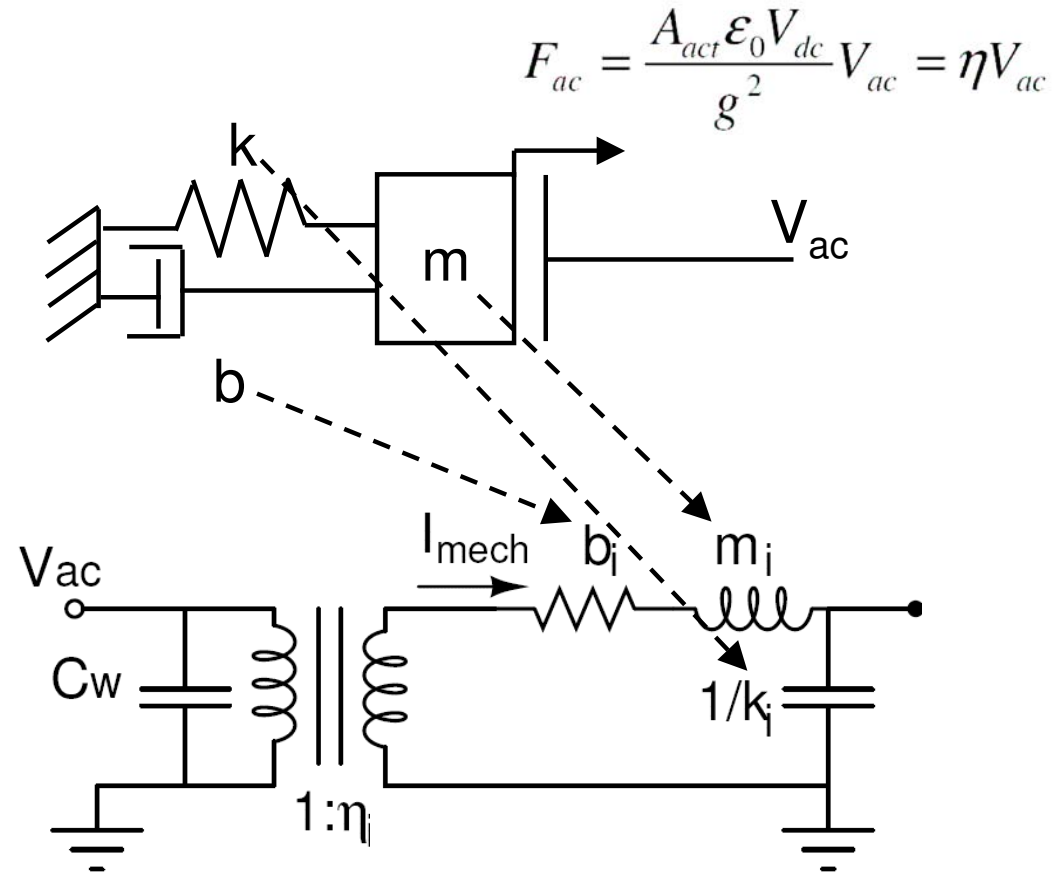
Parameter extraction

- ▶ Method to extract the 3 mechanical parameters by postprocessing of the eigenmode.



Equivalent circuit

- ▶ Assume everything is linear.
- ▶ Electrical admittance Y can be determined if k_i, m_i and b_i are known for all eigenmodes.



$$Y = \frac{i_{ac}}{V_{ac}} = j\omega C_w + \eta^2 \sum_{i=1}^N \left(j\omega m_i + b_i + \frac{k_i}{j\omega} \right)^{-1}$$

Determining m and k by postprocessing of eigenmodes

$$E_{tot} = E_{el,max} = \frac{1}{2} k_i |x_i|^2 = \left| \int_V W_s dV \right| \quad \text{Max. elastic energy}$$

$$E_{tot} = E_{kin,max} = \frac{1}{2} m_i |\omega_i x_i|^2 = \frac{1}{2} \left| \int_V \rho \omega_i \mathbf{u}_i^2 dV \right| \quad \text{Max. kinetic energy}$$

Therefore:

$$k_i = \frac{2}{|x_i|^2} \left| \int_V W_s dV \right|$$

$$m_i = \frac{k_i}{|\omega_i|^2} = \frac{1}{|x_i|^2} \left| \int_V \rho \mathbf{u}_i^2 dV \right|$$

Determining the damping coefficient b

- ▶ Damping in our resonators seems to be dominated by support losses:
 - Energy in traveling waves disappears via the anchors to the substrate.
- ▶ Substrate is very large. How to model the traveling waves?
 - Absorb them using an artificial boundary layer in the substrate.
 - Artificial material should have the following properties:
 - No reflection (matched layer).
 - Energy of traveling waves needs to be absorbed to prevent wave from coming back.
- ▶ Comsol 3.3: Perfectly Matched Layer(PML) in Structural Mechanics Module
 - Only available in frequency response analysis mode.
 - PMLs will be implemented in eigenfrequency analysis in future Comsol version.
 - Eigenfrequency analysis mode is much faster.

Matched layer (artificial material E' , ρ' , v')

- ▶ Zero reflection: $Z=Z'$

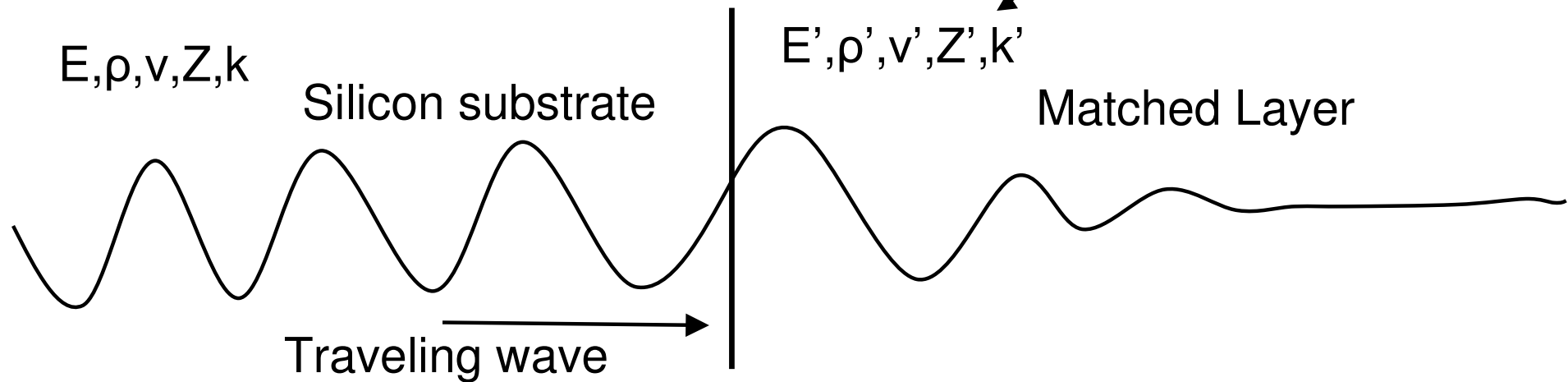
- ▶ Wave absorption: $\text{Im } \rho' < 0$

$$E' = jE / \alpha$$

$$\rho' = -j\alpha\rho$$

$$v' = v$$

- ▶ Only perfectly matched for normal incidence.



Determining b

- ▶ Complex material parameters of Matched Layer
- ▶ Therefore: Complex eigenfrequencies ω .

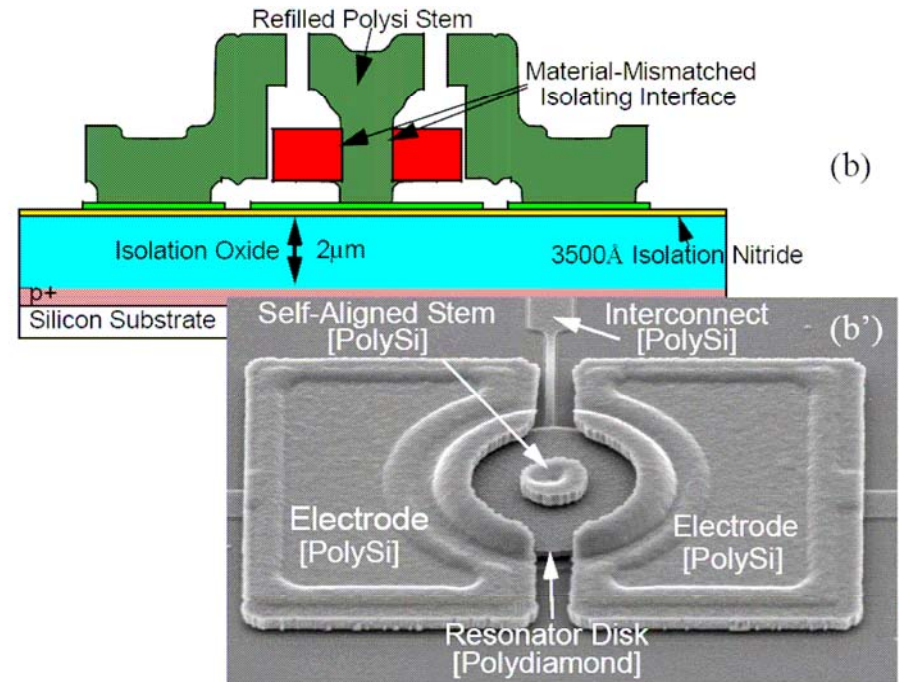
$$Q_i = \frac{\operatorname{Re} \omega_i}{2 \operatorname{Im} \omega_i}$$

- ▶ Damping coefficient b_i is obtained using:

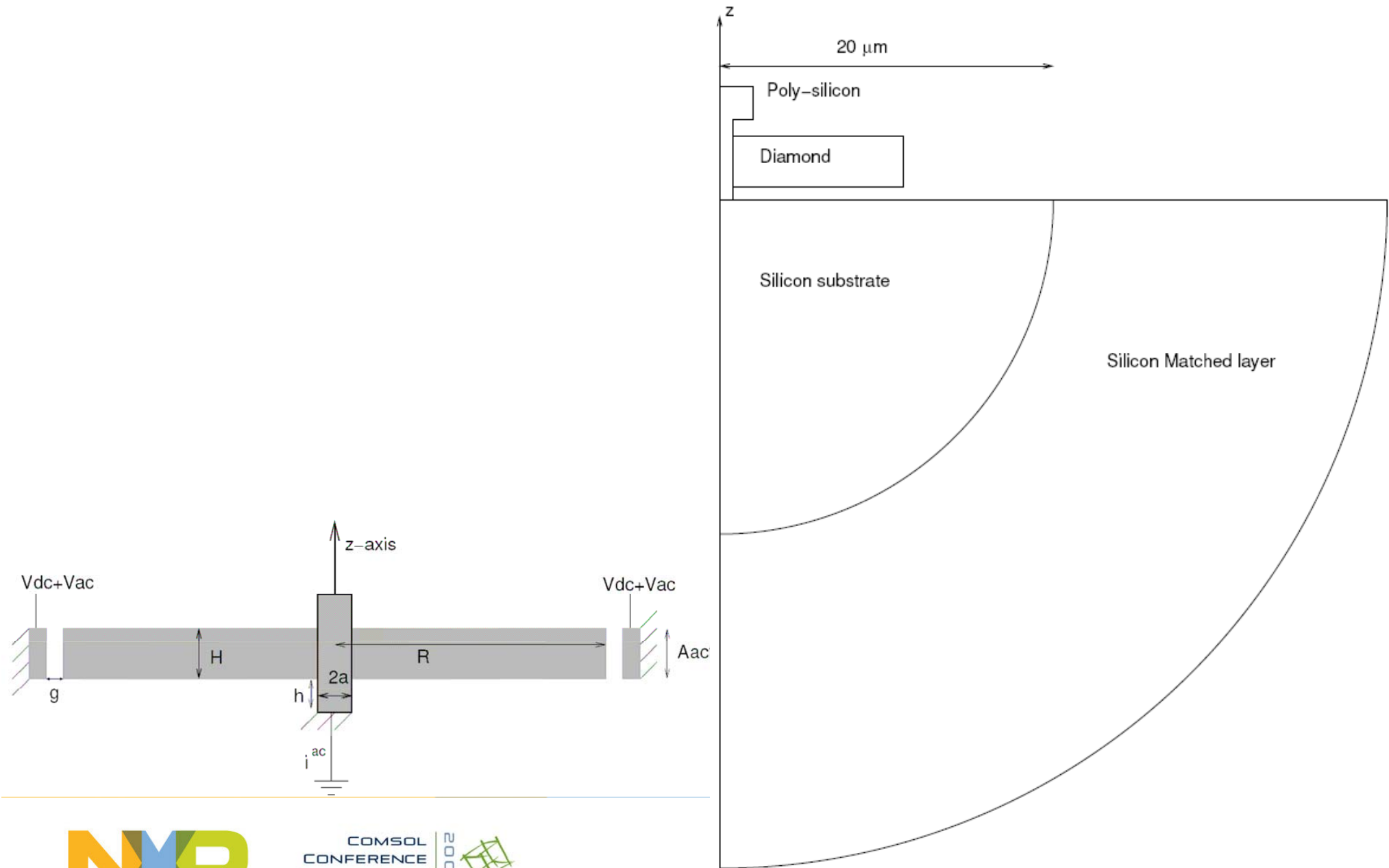
$$b_i = \frac{\sqrt{k_i m_i}}{Q_i}$$

Example: MEMS disk resonator

- ▶ Check method on diamond disk resonator
- ▶ J. Wang et al., 1.51-GHz Nanocrystalline Diamond Micromechanical Disk Resonator With Material-Mismatched Isolating Support, *Proc. MEMS 2004*, pp. 641-644.
- ▶ Analytically verified:
- ▶ Z. Hao and F. Ayazi, Support loss in the radial bulk-mode vibrations of center-supported micromechanical disk resonators, *Sensors and Actuators A*, **134**, p. 582-593 (2007)



Geometry (cylindrical symmetry)

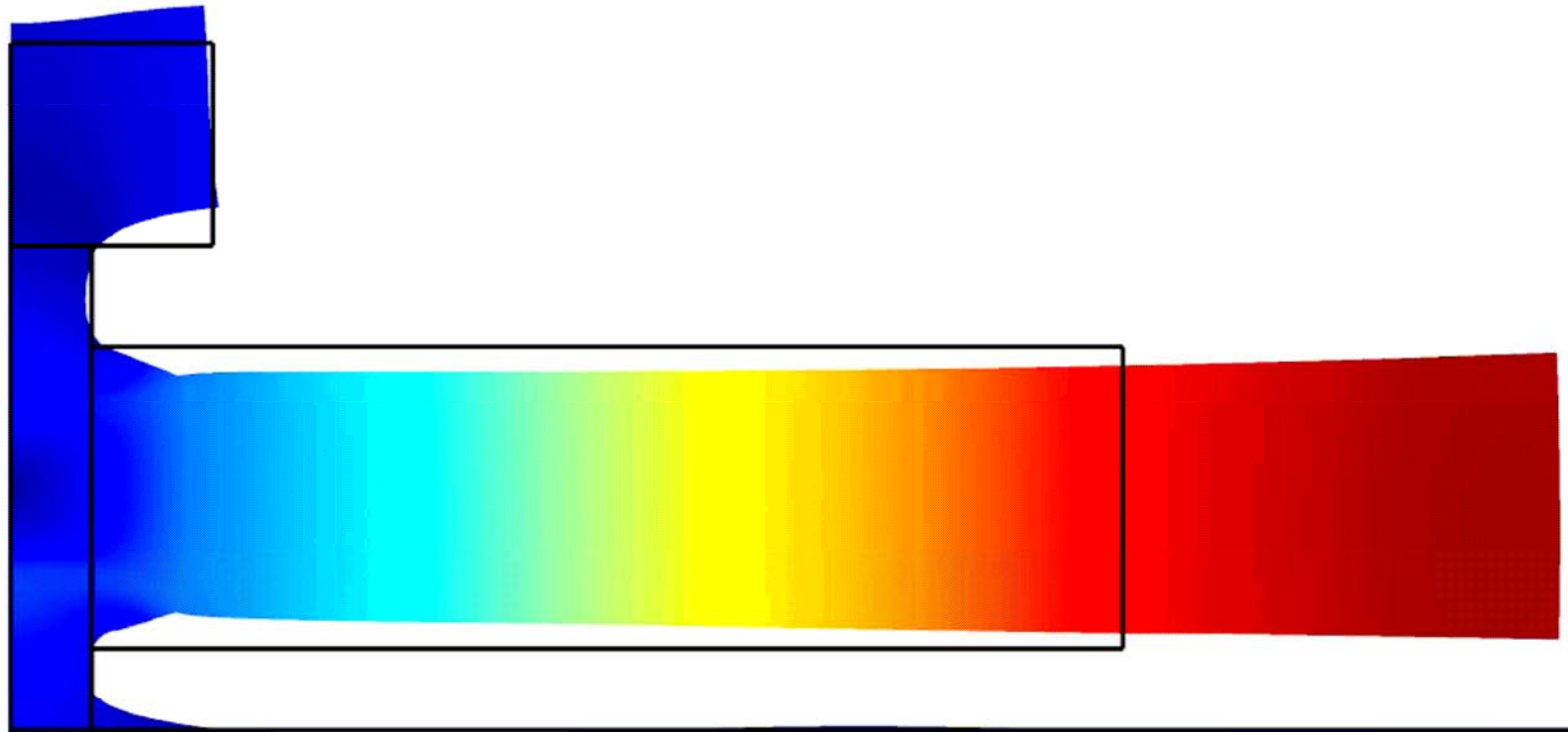


Script to analyze all eigenmodes

- ▶ Analyze all eigenmodes up to 700 MHz.
- ▶ Select modes with $Q > 10$.
- ▶ Dominant mode is selected using script.

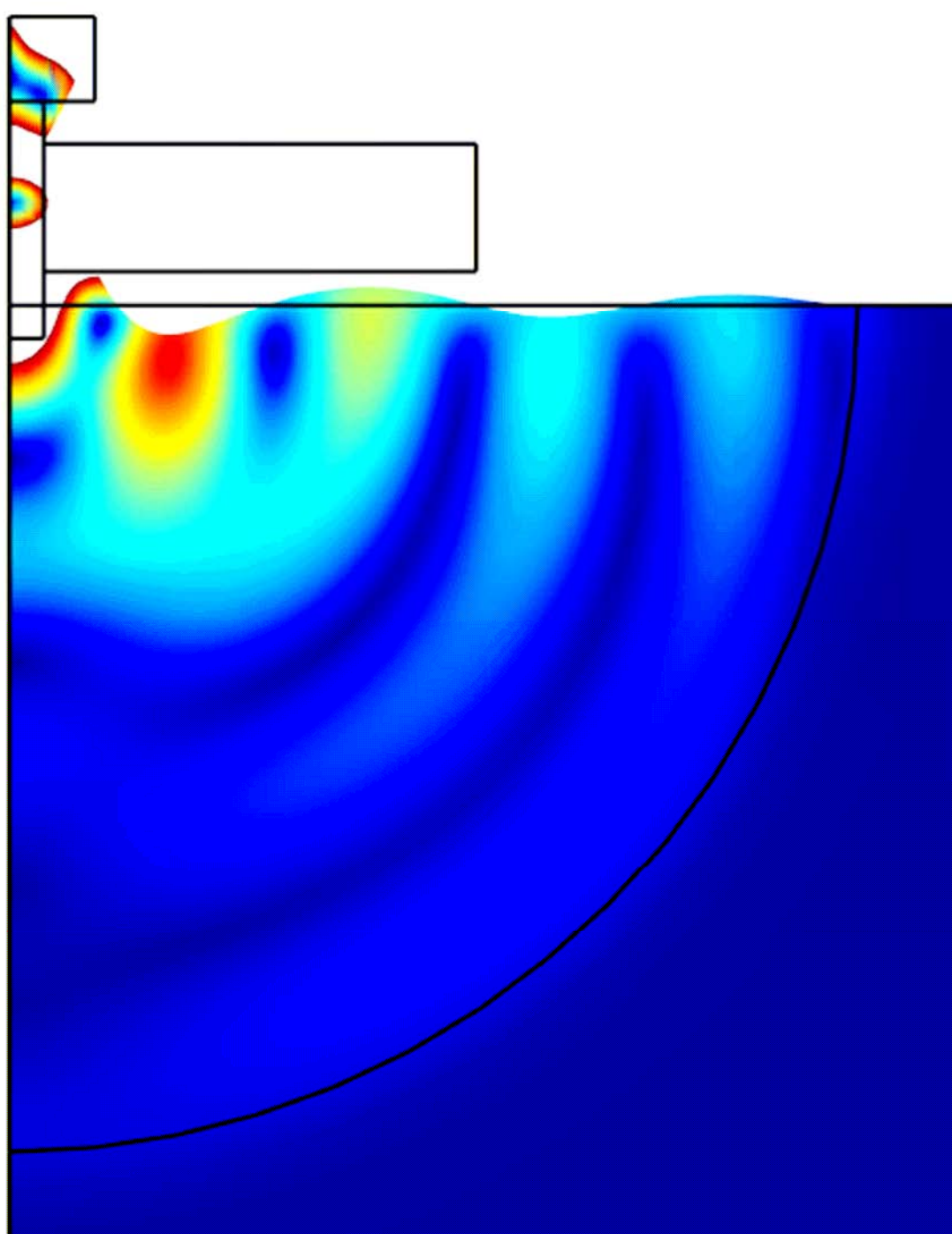
| fres (MHz) | k (N/m) | m(kg) | b (kg/s) | Q | Ymax (1/Ohm) |
|------------|----------|----------|-----------|---------|--------------|
| 26.34 | 4.41E+11 | 1.61E-05 | 77.1466 | 34.5267 | 1.12E-15 |
| 158.25 | 9.55E+11 | 9.66E-07 | 6.08278 | 157.914 | 1.42E-14 |
| 258.78 | 1.72E+11 | 6.50E-08 | 0.0307684 | 3433.51 | 2.80E-12 |
| 489.28 | 2.76E+07 | 2.92E-12 | 2.99E-07 | 30068.4 | 2.89E-07 |
| 579.70 | 4.76E+12 | 3.58E-07 | 7.46487 | 174.922 | 1.15E-14 |
| 630.49 | 3.15E+12 | 2.00E-07 | 78.2594 | 10.1447 | 1.10E-15 |

1st Disk mode



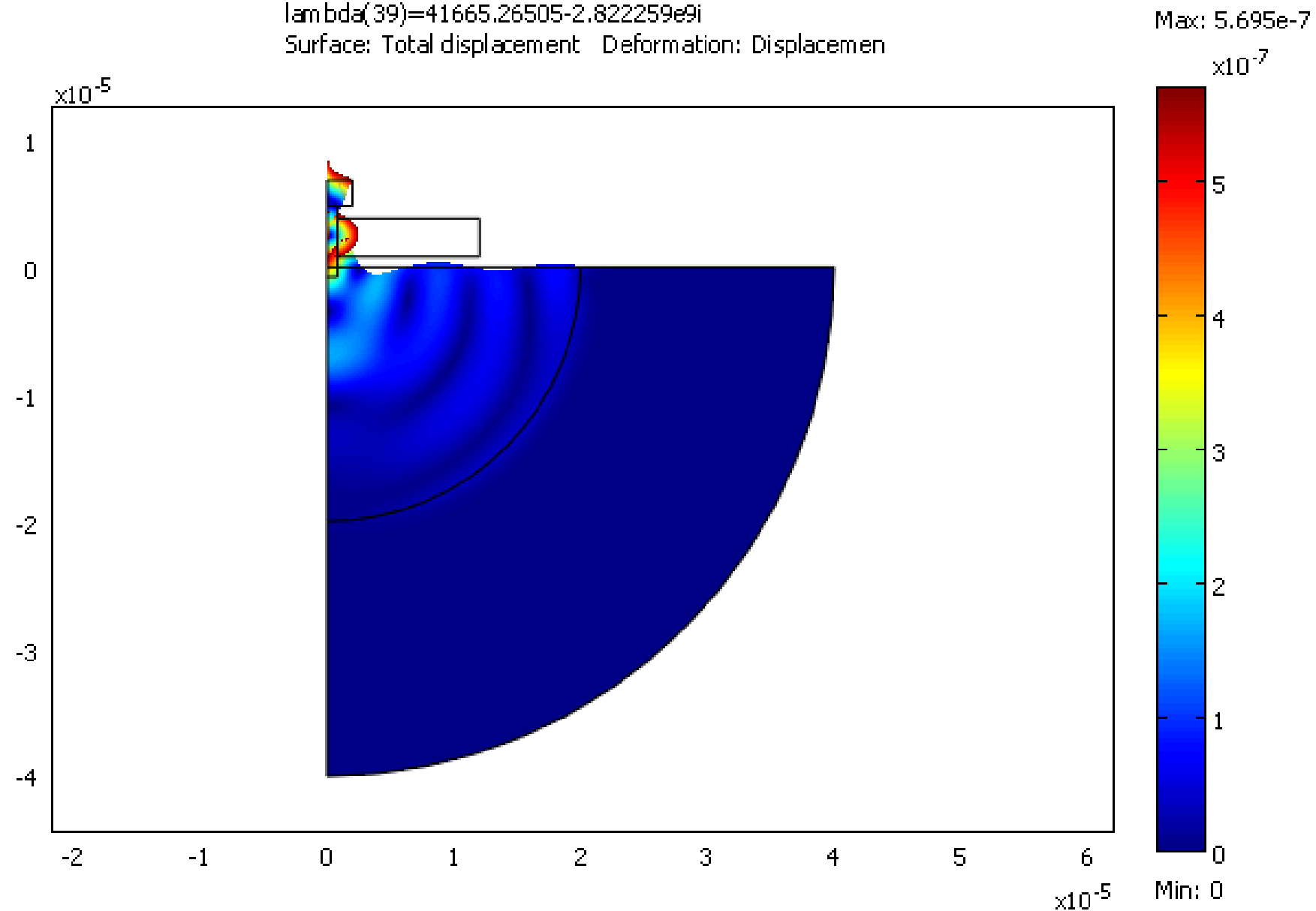
Total displacement in the first radial bulk-mode of the disk resonator at 489.27 MHz.

Acoustic waves traveling in the substrate

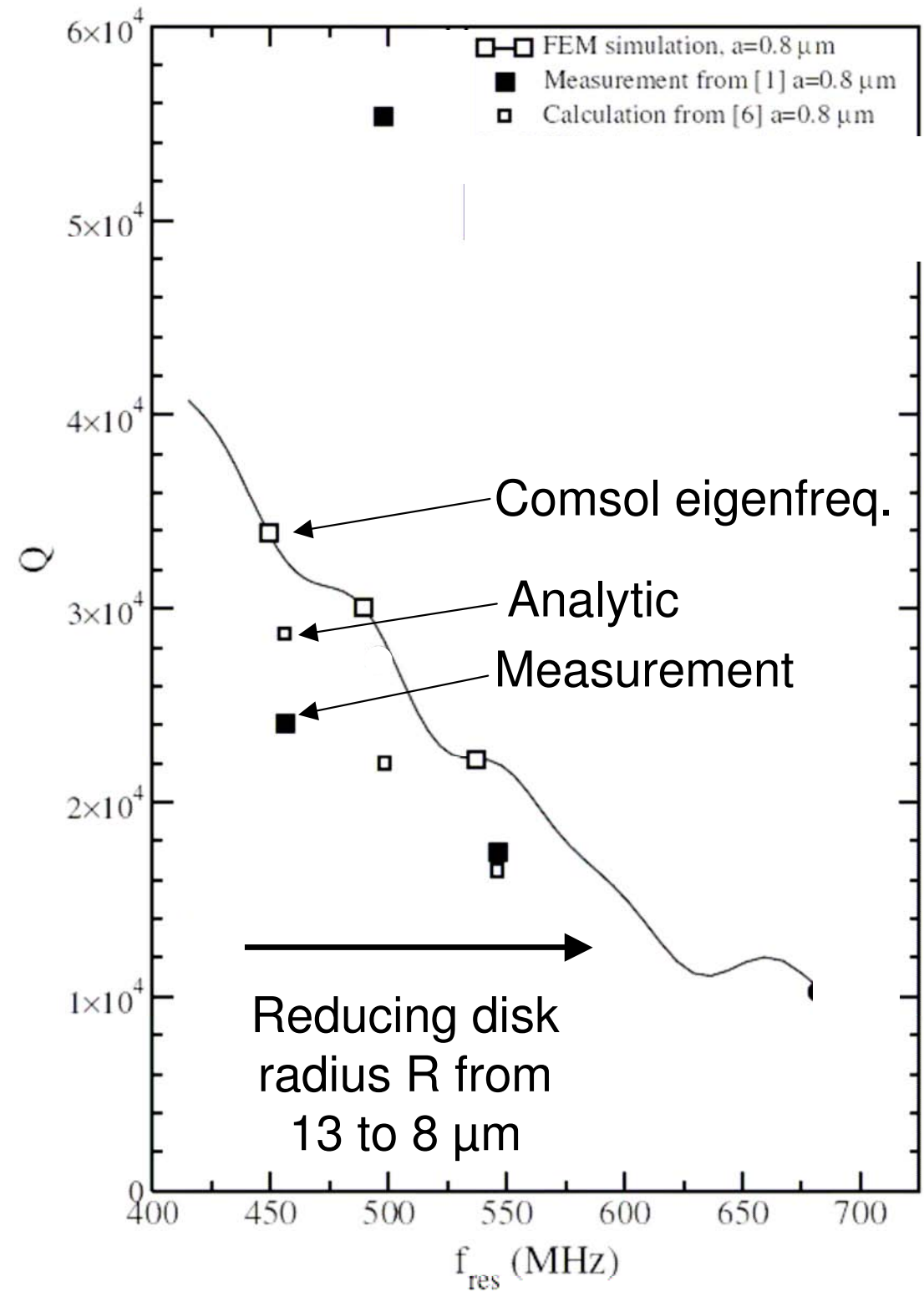


Acoustic waves traveling in the substrate

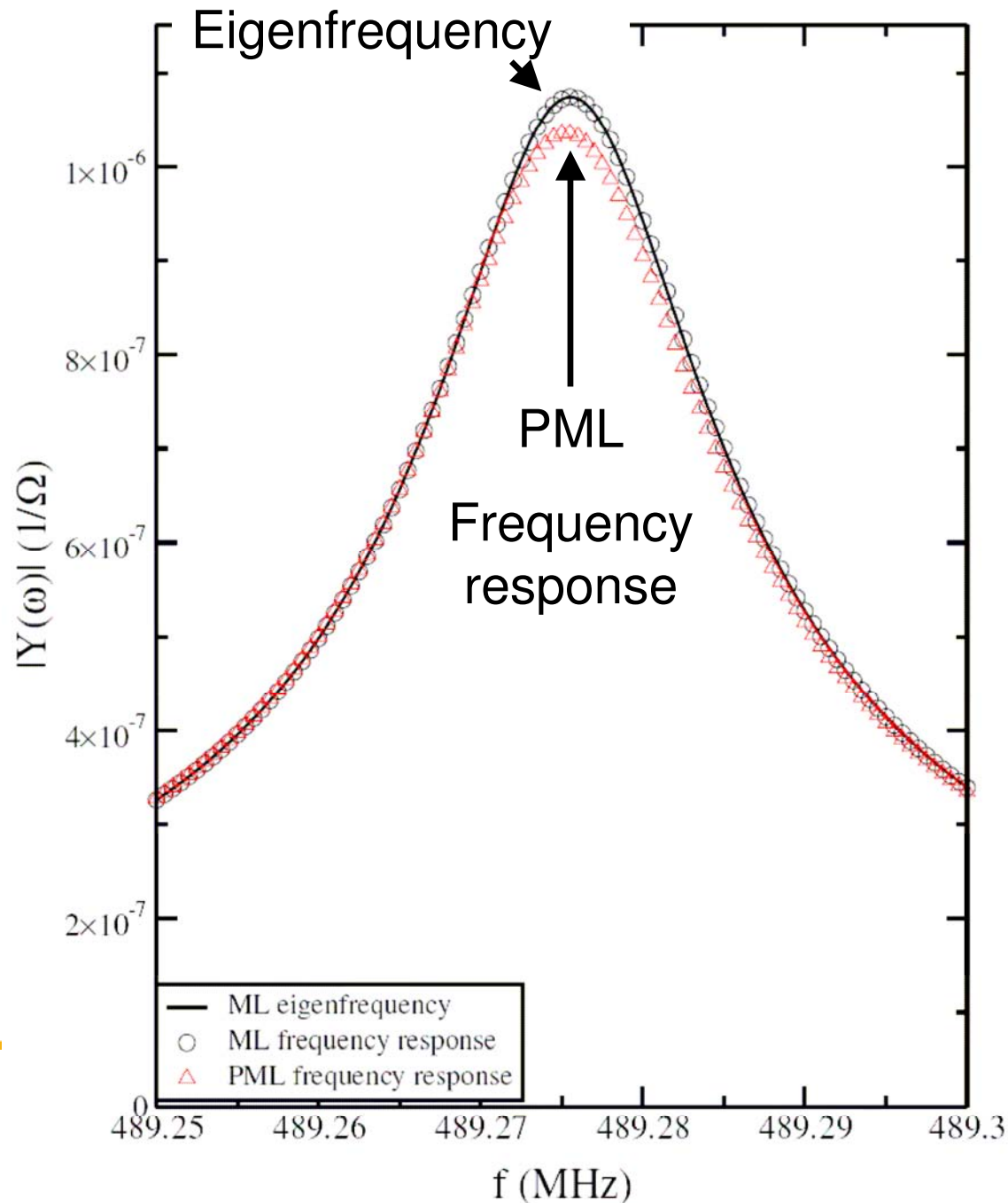
$\lambda(39)=41665.26505-2.822259e9i$
Surface: Total displacement Deformation: Displacemen



Measurement comparison



Comparison with frequency response and PML



- ▶ Eigenfrequency analysis 60x faster than frequency response.
- ▶ ML in good agreement with PML result.

Conclusions

- ▶ Simulation methods for electrostatic MEMS devices:
 - Static C-V curve of capacitive RF MEMS switches.
 - Position control efficiently implemented using Comsol ODE.
Reference article: J. Bielen and J. Stulemeijer, Proc. Eurosime 2007.
 - Admittance calculation of MEMS resonators
 - Support losses implemented using matched layer material model.
 - Equivalent parameter k, m and b extracted by postprocessing of eigenmodes.
 - Script to analyze all mode shapes.
 - See my Comsol 2007 proceedings article for more details.

